## Reliability Engineering

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## Contents

Prei	ace	······································
<b>1</b> 1.1		ility Engineering in the Twenty-First Century
1.1		s Quanty?
1.4	1.2.1	The Ability to Perform as Intended
	1.2.1	For a Specified Time
	1.2.3	Life-Cycle Conditions
	1.2.3	Reliability as a Relative Measure
1.3		Customer Satisfaction, and System Effectiveness
1.4		nance, Quality, and Reliability
1.5		lity and the System Life Cycle
1.6		uences of Failure
1.0	1.6.1	Financial Loss
	1.6.2	Breach of Public Trust
	1.6.3	Legal Liability
	1.6.4	Intangible Losses
1.7	Supplie	ers and Customers
1.8		ıry
		ns
2	Reliabi	ility Concepts19
2.1		Reliability Concepts
	2.1.1	Concept of Probability Density Function
2.2	Hazard	Rate
	2.2.1	Motivation and Development of Hazard Rate
	2.2.2	Some Properties of the Hazard Function
	2.2.3	Conditional Reliability
2.3	Percent	iles Product Life
2.4	Momen	nts of Time to Failure
	2.4.1	Moments about Origin and about the Mean
	2.4.2	Expected Life or Mean Time to Failure
	2.4.3	Variance or the Second Moment about the Mean
	2.4.4	Coefficient of Skewness
	2.4.5	Coefficient of Kurtosis

2.5	Summary Problems	
3	Probability and Life Distributions for Reliability Analysis	45
3.1	Discrete Distributions.	
	3.1.1 Binomial Distribution	
	3.1.2 Poisson Distribution	
	3.1.3 Other Discrete Distributions	
3.2	Continuous Distributions	
	3.2.1 Weibull Distribution	
	3.2.2 Exponential Distribution	
	3.2.3 Estimation of Reliability for Exponential Distribution	
	3.2.4 The Normal (Gaussian) Distribution	
	3.2.5 The Lognormal Distribution	
	3.2.6 Gamma Distribution.	
3.3	Probability Plots	
3.4	Summary	
	Problems	
4	Design for Six Sigma	
4.1	What Is Six Sigma?	
4.2	Why Six Sigma?	
4.3	How Is Six Sigma Implemented?	
	4.3.1 Steps in the Six Sigma Process	
	4.3.2 Summary of the Six Sigma Steps	
4.4	Optimization Problems in the Six Sigma Process	
	4.4.1 System Transfer Function	
	4.4.2 Variance Transmission Equation	
	4.4.3 Economic Optimization and Quality Improvement	
	4.4.4 Tolerance Design Problem	
4.5	Design for Six Sigma	
	4.5.1 Identify (I)	
	4.5.2 Characterize (C)	
	4.5.3 Optimize (O)	
	4.5.4 Verify (V)	
4.6	Summary	
	Problems	108
5	Product Development	111
5.1	Product Requirements and Constraints	112
5.2	Product Life Cycle Conditions	113
5.3	Reliability Capability	114
5.4	Parts and Materials Selection	114
5.5	Human Factors and Reliability	115
5.6	Deductive versus Inductive Methods	117
5.7	Failure Modes, Effects, and Criticality Analysis	117
5.8	Fault Tree Analysis	119
	5.8.1 Role of FTA in Decision-Making	121
	5.8.2 Steps of Fault Tree Analysis	

	5.8.3	Basic Paradigms for the Construction of Fault Trees	 . 122
	5.8.4	Definition of the Top Event	
	5.8.5	Faults versus Failures	
	5.8.6	Minimal Cut Sets	
5.9	Physics		
	5.9.1	Stress Margins	
	5.9.2	Model Analysis of Failure Mechanisms	
	5.9.3	Derating	
	5.9.4	Protective Architectures	
	5.9.5	Redundancy	
	5.9.6	Prognostics	
5.10	Design	Review	
5.11	_	cation	
5.12		acture and Assembly	
	5.12.1	Manufacturability	
	5.12.2	Process Verification Testing	
5.13	Analys	is, Product Failure, and Root Causes	
5.14	-	rry	
		ns	
6	Drodu	ct Requirements and Constraints	1/1
6.1		ng Requirements	
6.2		asibilities of the Supply Chain.	
0.2	6.2.1	Multiple-Customer Products	
	6.2.2	Single-Customer Products	
	6.2.3	Custom Products	
6.3		equirements Document	
6.4		eations.	
6.5		ements Tracking.	
6.6	_	ary	
0.0		ns	
	1100101		 177
<b>-</b> ,	1 14- 0-	and a Constitution of	
<b>7</b> 7.1		ycle Conditions	
7.1 7.2		g the Life-Cycle Profile	
1.2	7.2.1	Vole Events	
		Testing and Screening	
	7.2.3 7.2.4	Storage	
	7.2.4	Transportation	
	7.2.5	Installation	
	7.2.7	Operation	
7 2		Maintenance	
7.3	7.3.1	and Their Effects	
		Temperature	
	7.3.2	Humidity	
	7.3.3	Vibration and Shock	
	7.3.4	Solar Radiation	 155

	7.3.6	Pressure	157
	7.3.7	Chemicals	
	7.3.8	Sand and Dust	159
	7.3.9	Voltage	159
	7.3.10	Current	
	7.3.11	Human Factors	160
7.4	Consid	derations and Recommendations for LCP Development	
	7.4.1	Extreme Specifications-Based Design (Global and Local	
		Environments)	160
	7.4.2	Standards-Based Profiles	
	7.4.3	Combined Load Conditions	
	7.4.4	Change in Magnitude and Rate of Change of Magnitude	
7.5	Metho	ds for Estimating Life-Cycle Loads	
	7.5.1	Market Studies and Standards Based Profiles as Sources	
	7.50	of Data	
	7.5.2	In Situ Monitoring of Load Conditions	
	7.5.3	Field Trial Records, Service Records, and Failure Records	100
	7.5.4	Data on Load Histories of Similar Parts, Assemblies, or	1//
	<b>a</b>	Products	
7.6		ary	
	Proble	ms	16/
8	Reliab	oility Capability	169
8.1	Capab	ility Maturity Models	169
8.2	Key R	eliability Practices	170
	8.2.1	Reliability Requirements and Planning	170
	8.2.2	Training and Development	171
	8.2.3	Reliability Analysis	172
	8.2.4	Reliability Testing	172
	8.2.5	Supply-Chain Management	173
	8.2.6	Failure Data Tracking and Analysis	173
	8.2.7	Verification and Validation	174
	8.2.8	Reliability Improvement	174
8.3	Summ	ary	175
	Proble	ems	175
9	Parts	Selection and Management	177
9.1	Part A	Assessment Process	
	9.1.1	Performance Assessment	178
	9.1.2	Quality Assessment	179
	9.1.3	Process Capability Index	179
	9.1.4	Average Outgoing Quality	182
	9.1.5	Reliability Assessment	182
	9.1.6	Assembly Assessment	185
9.2	Parts 1	Management	185
	9.2.1	Supply Chain Management	185
	9.2.2	Part Change Management	186
	923	Industry Change Control Policies	187

9.3	Risk Management	188
9.4	Summary	190
	Problems	191
10	Failure Modes, Mechanisms, and Effects Analysis	
10.1	Development of FMMEA	
10.2	Failure Modes, Mechanisms, and Effects Analysis	
	10.2.1 System Definition, Elements, and Functions	
	10.2.2 Potential Failure Modes	
	10.2.3 Potential Failure Causes	
	10.2.4 Potential Failure Mechanisms	
	10.2.5 Failure Models	
	10.2.6 Life-Cycle Profile.	
	10.2.7 Failure Mechanism Prioritization	
	10.2.8 Documentation	
10.3	Case Study	
10.4	Summary	
	Problems	206
11	Probabilistic Design for Reliability and the Factor	
	of Safety	
11.1	Design for Reliability	
11.2	Design of a Tension Element	
11.3	Reliability Models for Probabilistic Design	209
11.4	Example of Probabilistic Design and Design for a	• • •
	Reliability Target	
11.5	Relationship between Reliability, Factor of Safety, and Variability	
11.6	Functions of Random Variables	
11.7	Steps for Probabilistic Design	
11.8	Summary	
	Problems	220
12	Derating and Uprating	222
12.1	Part Ratings	
12.1	12.1.1 Absolute Maximum Ratings.	
	12.1.1 Absolute Waximum Ratings.  12.1.2 Recommended Operating Conditions	
	12.1.2 Recommended Operating Conditions  12.1.3 Factors Used to Determine Ratings	
12.2	Derating	
1 4.4	12.2.1 How Is Derating Practiced?	
	12.2.2 Limitations of the Derating Methodology	
	12.2.3 How to Determine These Limits	
12.3	Uprating	
12.3	12.3.1 Parts Selection and Management Process	
	<u> </u>	
	1	
	12.3.3 Methods of Uprating	
12.4	Summary	
14.4	Problems	245 246
	LIVIDA DIA	/40

13	Reliability Estimation Techniques	247
13.1	Tests during the Product Life Cycle	
	13.1.1 Concept Design and Prototype	
	13.1.2 Performance Validation to Design Specification	
	13.1.3 Design Maturity Validation	
	13.1.4 Design and Manufacturing Process Validation	
	13.1.5 Preproduction Low Volume Manufacturing	
	13.1.6 High Volume Production	
	13.1.7 Feedback from Field Data	
13.2	Reliability Estimation	
13.3	Product Qualification and Testing	
	13.3.1 Input to PoF Qualification Methodology	
	13.3.2 Accelerated Stress Test Planning and Development	
	13.3.3 Specimen Characterization	
	13.3.4 Accelerated Life Tests	
	13.3.5 Virtual Testing	
	13.3.6 Virtual Qualification	
	13.3.7 Output	
13.4	Case Study: System-in-Package Drop Test Qualification	
	13.4.1 Step 1: Accelerated Test Planning and Development	
	13.4.2 Step 2: Specimen Characterization	
	13.4.3 Step 3: Accelerated Life Testing	
	13.4.4 Step 4: Virtual Testing	
	13.4.5 Global FEA	
	13.4.6 Strain Distributions Due to Modal Contributions	
	13.4.7 Acceleration Curves	
	13.4.8 Local FEA	
	13.4.9 Step 5: Virtual Qualification	
	13.4.10 PoF Acceleration Curves	
	13.4.11 Summary of the Methodology for Qualification	
13.5	Basic Statistical Concepts	
10.0	13.5.1 Confidence Interval	
	13.5.2 Interpretation of the Confidence Level	
	13.5.3 Relationship between Confidence Interval and Sample Size.	279
13.6	Confidence Interval for Normal Distribution	
	13.6.1 Unknown Mean with a Known Variance for	
	Normal Distribution	279
	13.6.2 Unknown Mean with an Unknown Variance for	
	Normal Distribution	280
	13.6.3 Differences in Two Population Means with	
	Variances Known	281
13.7	Confidence Intervals for Proportions	
13.8	Reliability Estimation and Confidence Limits for	
10.0	Success–Failure Testing	283
	13.8.1 Success Testing	
13.9	Reliability Estimation and Confidence Limits for	
	Exponential Distribution	287
13.10	Summary	292
	Problems	

14	Process Control and Process Capability	. 295
14.1	Process Control System	
	14.1.1 Control Charts: Recognizing Sources of Variation	297
	14.1.2 Sources of Variation	297
	14.1.3 Use of Control Charts for Problem Identification	
14.2	Control Charts	299
	14.2.1 Control Charts for Variables	306
	14.2.2 X-Bar and R Charts	306
	14.2.3 Moving Range Chart Example	308
	14.2.4 X-Bar and S Charts	311
	14.2.5 Control Charts for Attributes	312
	14.2.6 <i>p</i> Chart and <i>np</i> Chart	312
	14.2.7 <i>np</i> Chart Example	313
	14.2.8 <i>c</i> Chart and <i>u</i> Chart	314
	14.2.9 <i>c</i> Chart Example	315
14.3	Benefits of Control Charts	
14.4		
	14.4.1 Process Capability Studies	
14.5	Advanced Control Charts	
	14.5.1 Cumulative Sum Control Charts	
	14.5.2 Exponentially Weighted Moving Average Control Charts	
	14.5.3 Other Advanced Control Charts	
14.6	Summary	
	Problems	326
15	Product Screening and Burn-In Strategies	. 331
	Treamer coresiming and man minimized specifications and specifications and specifications and specifications are specifications.	
15.1	Burn-In Data Observations	332
15.1 15.2	Burn-In Data Observations	332
15.2	Discussion of Burn-In Data	332
15.2 15.3	Discussion of Burn-In Data	332
15.2 15.3 15.4	Discussion of Burn-In Data	332 333 334 335
15.2 15.3	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.	332 333 334 335 336
15.2 15.3 15.4	Discussion of Burn-In Data	332 333 334 335 336
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.	332 333 334 335 336 337
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.	332 333 334 335 336 337
15.2 15.3 15.4 15.5	Discussion of Burn-In Data. Higher Field Reliability without Screening. Best Practices Summary. Problems  Analyzing Product Failures and Root Causes Root-Cause Analysis Processes	332 333 334 335 336 337
15.2 15.3 15.4 15.5	Discussion of Burn-In Data. Higher Field Reliability without Screening. Best Practices Summary. Problems  Analyzing Product Failures and Root Causes Root-Cause Analysis Processes 16.1.1 Preplanning.	332 333 334 335 336 337
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate	332 333 334 335 336 337
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes.	332 333 334 335 336 337 341 343
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate  Causes.  16.1.3 Root-Cause Hypothesization.	332 333 334 335 336 337 341 341 343 344
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes  16.1.3 Root-Cause Hypothesization  16.1.4 Analysis and Interpretation of Evidence.	332 333 334 335 336 337 341 341 343 344 348
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes.  16.1.3 Root-Cause Hypothesization  16.1.4 Analysis and Interpretation of Evidence.  16.1.5 Root-Cause Identification and Corrective Actions.	332 333 334 335 336 337 341 341 343 344 348
15.2 15.3 15.4 15.5 <b>16</b> 16.1	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices  Summary.  Problems  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes.  16.1.3 Root-Cause Hypothesization  16.1.4 Analysis and Interpretation of Evidence.  16.1.5 Root-Cause Identification and Corrective Actions  16.1.6 Assessment of Corrective Actions	332 333 334 335 336 337 341 341 343 344 348 350
15.2 15.3 15.4 15.5	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices  Summary.  Problems  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes  16.1.3 Root-Cause Hypothesization  16.1.4 Analysis and Interpretation of Evidence.  16.1.5 Root-Cause Identification and Corrective Actions  16.1.6 Assessment of Corrective Actions  No-Fault-Found	332 333 334 335 336 337 341 341 343 344 348 350 351
15.2 15.3 15.4 15.5 <b>16</b> 16.1	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes.  16.1.3 Root-Cause Hypothesization  16.1.4 Analysis and Interpretation of Evidence.  16.1.5 Root-Cause Identification and Corrective Actions.  16.1.6 Assessment of Corrective Actions.  No-Fault-Found.  16.2.1 An Approach to Assess NFF.	. 332 . 333 . 334 . 335 . 336 . 337 . 341 . 341 . 343 . 344 . 348 . 350 . 351
15.2 15.3 15.4 15.5 <b>16</b> 16.1	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes.  16.1.3 Root-Cause Hypothesization.  16.1.4 Analysis and Interpretation of Evidence.  16.1.5 Root-Cause Identification and Corrective Actions.  16.1.6 Assessment of Corrective Actions.  No-Fault-Found.  16.2.1 An Approach to Assess NFF.  16.2.2 Common Mode Failure.	. 332 . 333 . 334 . 335 . 336 . 337 . 341 . 341 . 343 . 344 . 348 . 350 . 351 . 353 . 355
15.2 15.3 15.4 15.5 <b>16</b> 16.1	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes.  16.1.3 Root-Cause Hypothesization  16.1.4 Analysis and Interpretation of Evidence.  16.1.5 Root-Cause Identification and Corrective Actions  16.1.6 Assessment of Corrective Actions.  No-Fault-Found.  16.2.1 An Approach to Assess NFF.  16.2.2 Common Mode Failure.  16.2.3 Concept of Common Mode Failure.	. 332 . 333 . 334 . 335 . 336 . 337 . 341 . 341 . 343 . 344 . 348 . 350 . 351 . 353 . 355
15.2 15.3 15.4 15.5 <b>16</b> 16.1	Discussion of Burn-In Data.  Higher Field Reliability without Screening.  Best Practices.  Summary.  Problems.  Analyzing Product Failures and Root Causes.  Root-Cause Analysis Processes  16.1.1 Preplanning.  16.1.2 Collecting Data for Analysis and Assessing Immediate Causes.  16.1.3 Root-Cause Hypothesization.  16.1.4 Analysis and Interpretation of Evidence.  16.1.5 Root-Cause Identification and Corrective Actions.  16.1.6 Assessment of Corrective Actions.  No-Fault-Found.  16.2.1 An Approach to Assess NFF.  16.2.2 Common Mode Failure.	. 332 . 333 . 334 . 335 . 336 . 337 . 341 . 341 . 343 . 344 . 348 . 350 . 351 . 353 . 355

	16.2.5 Common Mode Failure Root Causes	
	16.2.6 Common Mode Failure Analysis	
	16.2.7 Common Mode Failure Occurrence and Impact Reduction	366
16.3	Summary	
	Problems	374
17	System Reliability Modeling	
17.1	Reliability Block Diagram	
17.2	Series System.	
17.3	Products with Redundancy	
	17.3.1 Active Redundancy	
	17.3.2 Standby Systems	
	17.3.3 Standby Systems with Imperfect Switching	
	17.3.4 Shared Load Parallel Models	
	17.3.5 ( <i>k</i> , <i>n</i> ) Systems	
	17.3.6 Limits of Redundancy	
17.4	Complex System Reliability	
	17.4.1 Complete Enumeration Method	
	17.4.2 Conditional Probability Method	
	17.4.3 Concept of Coherent Structures	
17.5	Summary	
	Problems	402
40	11life \$5ite-day, and Duramacking	400
18	Health Monitoring and Prognostics	
18.1	Conceptual Model for Prognostics	
18.2	Reliability and Prognostics	
18.3	PHM for Electronics	
18.4	PHM Concepts and Methods	
18.5	Monitoring and Reasoning of Failure Precursors	
10.3	18.5.1 Monitoring Environmental and Usage Profiles for	420
	Damage Modeling	424
18.6	Implementation of PHM in a System of Systems	429
18.7	Summary	
10.7	Problems	
	1 TOOLCHIS	., 451
19	Warranty Analysis	433
19.1		
19.2	Warranty Return Information	
19.3	Warranty Policies	
19.4	Warranty and Reliability	
19.5	Warranty Cost Analysis	
	19.5.1 Elements of Warranty Cost Models	
	19.5.2 Failure Distributions	
	19.5.3 Cost Modeling Calculation	440
	19.5.4 Modeling Assumptions and Notation	441
	19.5.5 Cost Models Examples	442
	19.5.6 Information Needs	
	19.5.7 Other Cost Models	

19.6 Warranty and Reliability Management         19.7 Summary         Problems	449
Appendix A: Some Useful Integrals	451
Appendix B: Table for Gamma Function	453
Appendix C: Table for Cumulative Standard Normal Distribution	455
Appendix D: Values for the Percentage Points $t_{lpha, u}$ of the $t$ -Distribution	457
Appendix E: Percentage Points $\chi^2_{lpha, u}$ of the Chi-Square Distribution	461
Appendix F: Percentage Points for the <i>F</i> -Distribution	467
Bibliography	473
ndev	107